

Notice of References Cited	Application/Control No. 10/556,225		Applicant(s)/Patent Under Reexamination KOHNKE, AXEL	
	Examiner Michael C. Lai		Art Unit 2157	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,305,372	04-1994	Tomiyori, Yutaka	455/564
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*	N	WO 03/024079 A2	03-2003	WO	De Beer, Leon	379/221.01
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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